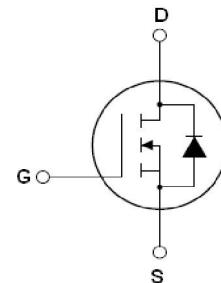


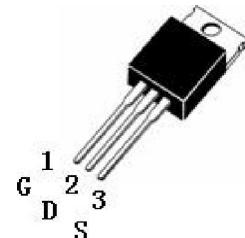
**FEATURES**

- Advanced trench process technology
- avalanche energy, 100% test
- Fully characterized avalanche voltage and current
- Lead free product

**ID =75A**  
**BV=100V**  
**R<sub>DS (ON)</sub> =16mΩ (Max.)**


**DESCRIPTION**

The SSF1016 is a new generation of high voltage and low current N-Channel enhancement mode trench power MOSFET. This new technology increases the device reliability and electrical parameter repeatability. SSF1016 is assembled in high reliability and qualified assembly house.


**APPLICATIONS**

- Power switching application

**SSF1016 Top View (TO-220)**
**Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @T <sub>c</sub> =25°C	Continuous drain current,VGS@10V	75	A
I <sub>D</sub> @T <sub>c</sub> =100°C	Continuous drain current,VGS@10V	65	
I <sub>DM</sub>	Pulsed drain current ①	300	
P <sub>D</sub> @T <sub>C</sub> =25C	Power dissipation	273	W
	Linear derating factor	1.5	W/C
V <sub>GS</sub>	Gate-to-Source voltage	±20	V
E <sub>AS</sub>	Single pulse avalanche energy ②	380	mJ
E <sub>AR</sub>	Repetitive avalanche energy	TBD	mJ
dv/dt	Peak diode recovery voltage	31	v/ns
T <sub>J</sub>	Operating Junction and		
T <sub>STG</sub>	Storage Temperature Range	–55 to +175	°C

**Thermal Resistance**

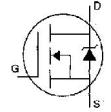
	Parameter	Min.	Typ.	Max.	Units
R <sub>θJC</sub>	Junction-to-case	—	0.55	—	C/W
R <sub>θJA</sub>	Junction-to-ambient	—	—	62	

**Electrical Characteristics @T<sub>J</sub>=25 °C (unless otherwise specified)**

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
BV <sub>DSS</sub>	Drain-to-Source breakdown voltage	100	—	—	V	V <sub>GS</sub> =0V,I <sub>D</sub> =250μA
R <sub>DS(on)</sub>	Static Drain-to-Source on-resistance	—	11	16	mΩ	V <sub>GS</sub> =10V,I <sub>D</sub> =30A
V <sub>GS(th)</sub>	Gate threshold voltage	2.0	—	4.0	V	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =250μA
I <sub>DSS</sub>	Drain-to-Source leakage current	—	—	2	μA	V <sub>DS</sub> =100V,V <sub>GS</sub> =0V
		—	—	10		V <sub>DS</sub> =100V, V <sub>GS</sub> =0V,T <sub>J</sub> =150°C
I <sub>GSS</sub>	Gate-to-Source forward leakage	—	—	100	nA	V <sub>GS</sub> =20V

	Gate-to-Source reverse leakage	—	—	-100		V <sub>GS</sub> =-20V
Q <sub>g</sub>	Total gate charge	—	90	—	nC	I <sub>D</sub> =30A, V <sub>GS</sub> =10V V <sub>DD</sub> =30V
Q <sub>gs</sub>	Gate-to-Source charge	—	20	—		
Q <sub>gd</sub>	Gate-to-Drain("Miller") charge	—	31	—		
t <sub>d(on)</sub>	Turn-on delay time	—	18.2	—	nS	V <sub>DD</sub> =30V I <sub>D</sub> =2A, R <sub>L</sub> =15Ω R <sub>G</sub> =2.5Ω V <sub>GS</sub> =10V
t <sub>r</sub>	Rise time	—	15.6	—		
t <sub>d(off)</sub>	Turn-Off delay time	—	70.5	—		
t <sub>f</sub>	Fall time	—	13.8	—	pF	V <sub>GS</sub> =0V V <sub>DS</sub> =25V f=1.0MHZ
C <sub>iss</sub>	Input capacitance	—	3150	—		
C <sub>oss</sub>	Output capacitance	—	350	—		
C <sub>rss</sub>	Reverse transfer capacitance	—	240	—		

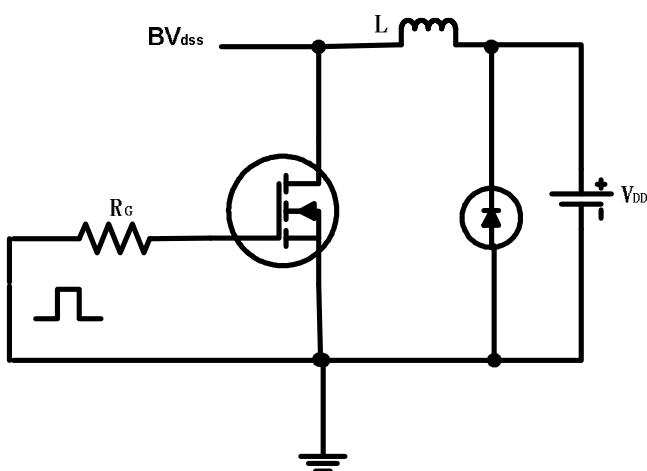
### Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Test Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)	—	—	75	A	MOSFET symbol showing the integral reverse p-n junction diode.
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①	—	—	300		
V <sub>SD</sub>	Diode Forward Voltage	—	—	1.3	V	T <sub>J</sub> =25°C, I <sub>S</sub> =60A, V <sub>GS</sub> =0V ③
t <sub>rr</sub>	Reverse Recovery Time	—	57	—	nS	T <sub>J</sub> =25°C, I <sub>F</sub> =75A di/dt=100A/μs ③
Q <sub>rr</sub>	Reverse Recovery Charge	—	107	—	μC	
t <sub>on</sub>	Forward Turn-on Time	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>s</sub> + LD)				

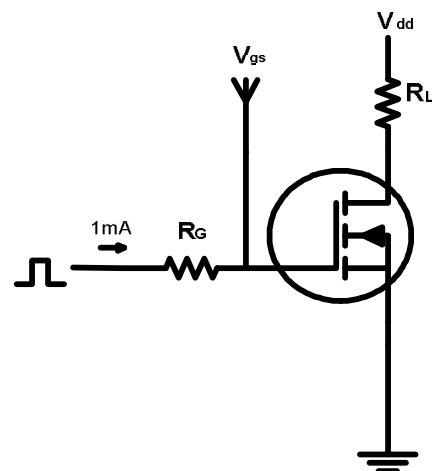
Notes:

- ① Repetitive rating; pulse width limited by max junction temperature.
- ② Test condition: L =0.3mH, V<sub>DD</sub> = 50V, I<sub>D</sub>=37A
- ③ Pulse width≤300μS, duty cycle≤1.5% ; R<sub>G</sub> = 25Ω Starting T<sub>J</sub> = 25°C

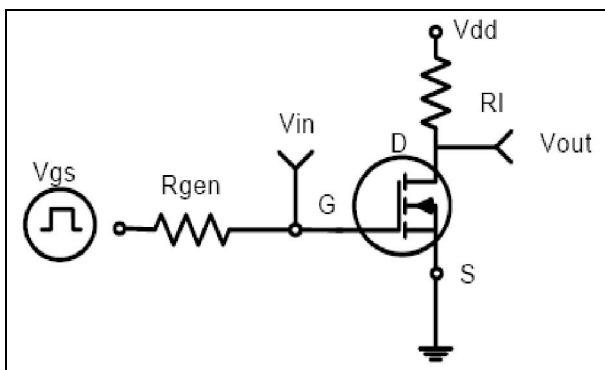
EAS Test Circuit



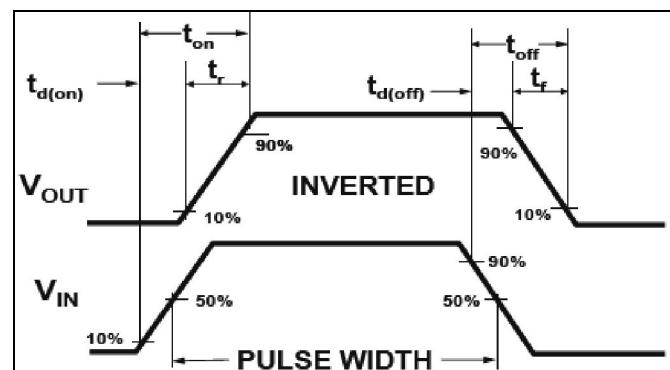
Gate Charge Test Circuit

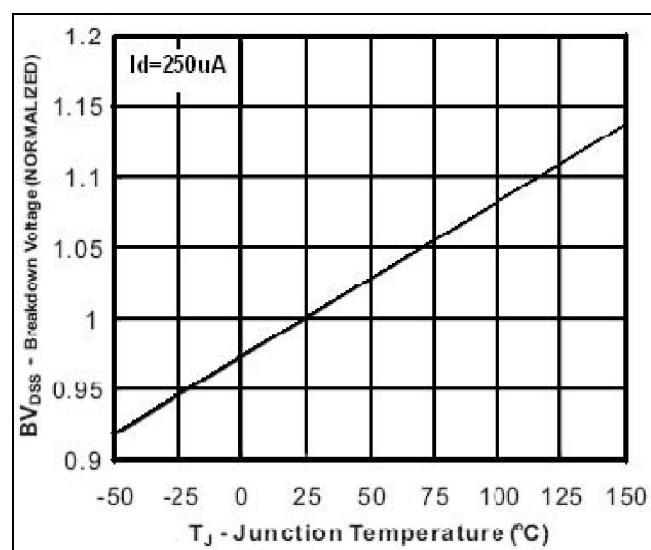
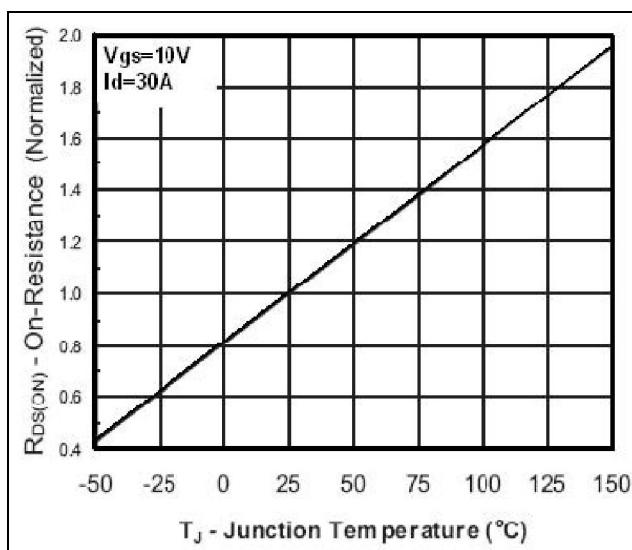
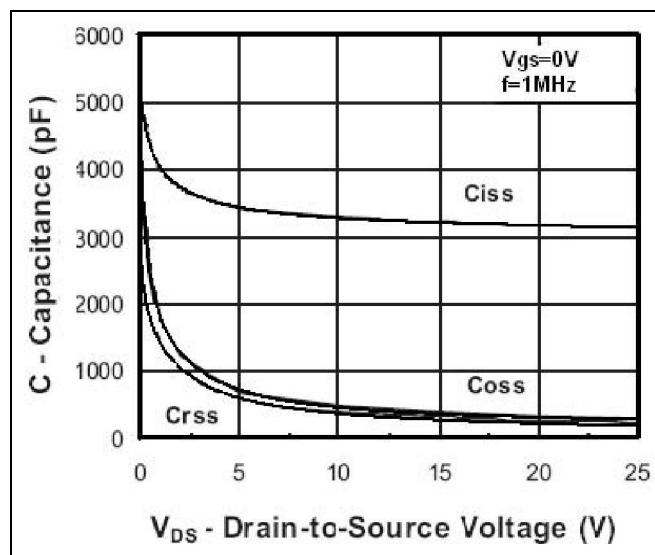
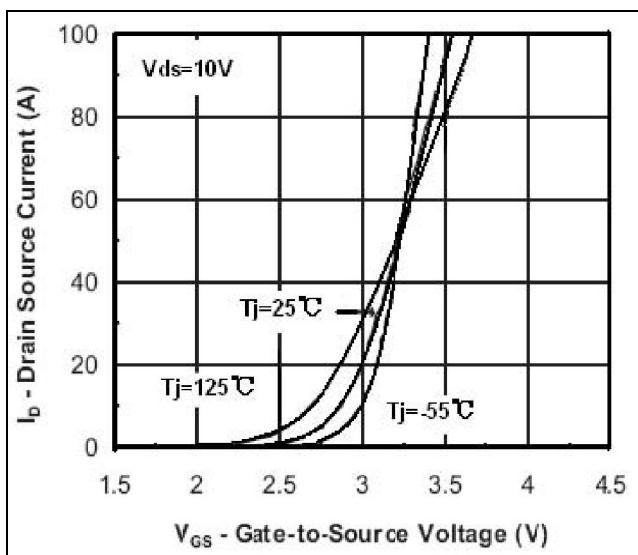


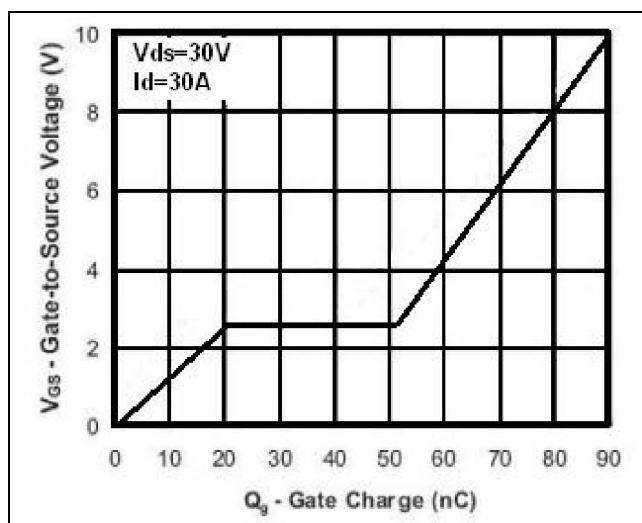
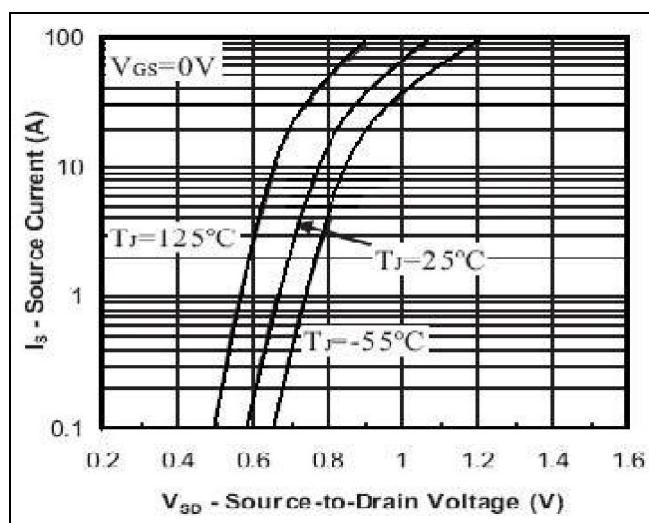
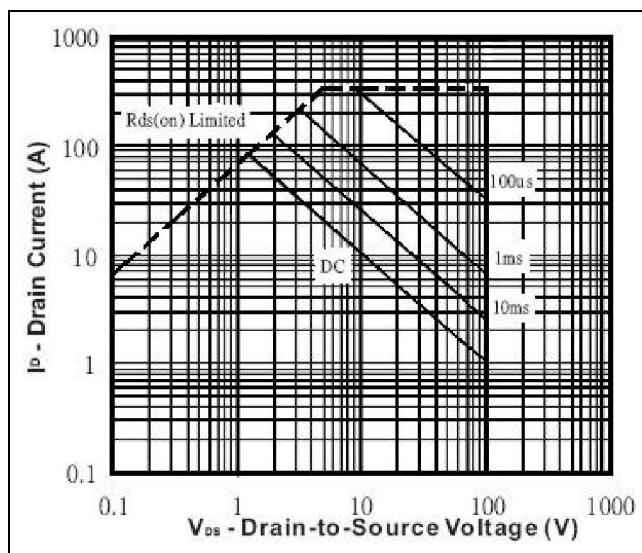
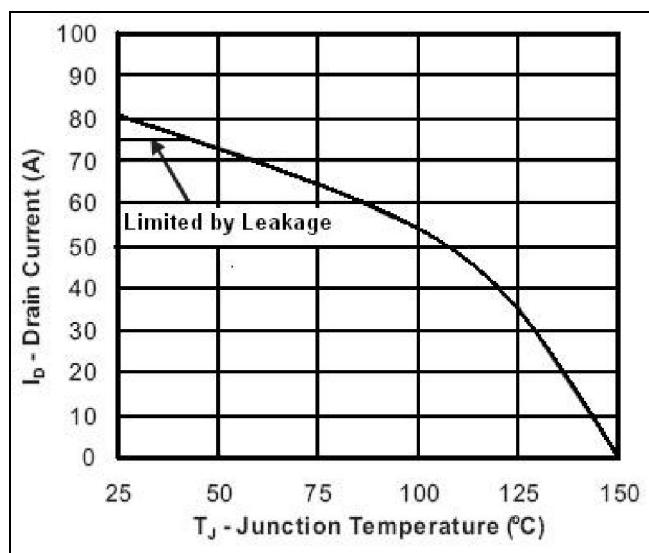
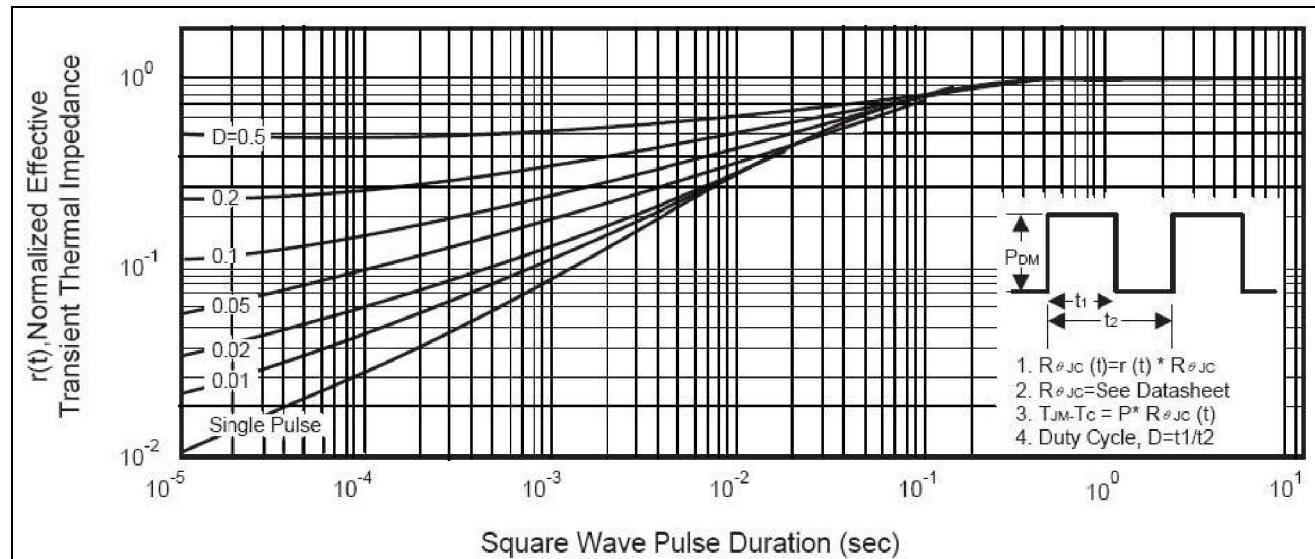
**Switch Time Test Circuit**

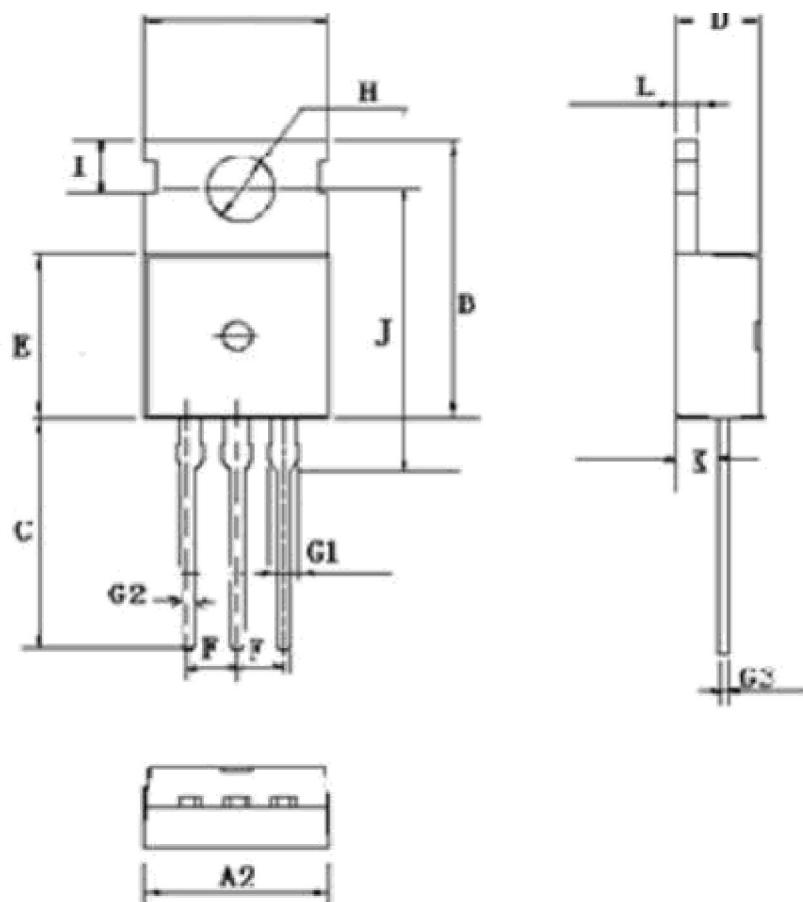


**Switch Waveform**






**Gate Charge**

**Source-Drain Diode Forward Voltage**

**Safe Operation Area**

**Max Drain Current vs. Junction**

**Transient Thermal Impedance Curve**

**TO-220 MECHANICAL DATA**


SYMBOL	DIMENSIONS
A(mm)	9.66~10.28
A2(mm)	9.80~10.20
B(mm)	15.6~15.8
C(mm)	12.70~14.27
D(mm)	4.30~4.70
E(mm)	8.59~9.40
F(mm)	2.54 (nom)
G1(mm)	1.42~1.62
G2(mm)	0.70~0.95
G3(mm)	0.45~0.60
H(mm) dia.	3.50~3.70
I(mm)	2.7~2.9
J(mm)	15.70~16.25
K(mm)	2.20~2.90
L(mm)	1.15~1.40
M(mm)	0.5